


Search Notes 	Application/Control No. 10594190	Applicant(s)/Patent Under Reexamination CHEN, YIYOU
	Examiner Michael Szperka	Art Unit 1644

SEARCHED			
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SEARCH NOTES		
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inventor search in eDAN: Chen, Yiyu	2/10/10	MS
USPAT USPGPUB EPO JPO DERWENT (EAST) see search printout	2/10/10	MS
MEDLINE AGRICOLA BIOSIS CAPLUS EMBASE SCISEARCH (STN) see search printout	2/10/10	MS

INTERFERENCE SEARCH			
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